

CALL FOR PAPERS

IMPORTANT DATES

30 June 2025

Paper Submission Opens

7 September 2025

Paper Submission Closes

Option B: for Direct to Sensors Letters

28 September 2025

Paper Submission Closes

Option A: Submission to the conference

17 November 2025

Notification of Acceptance

1 December 2025

Author Registration Opens

21 December 2025

Final Submission Closes

12 January 2026

Author Registration Closes

19 January 2026

Early Bird Registration Closes

ORGANIZING COMMITTEE

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Group VC, BITS Pilani Campuses, India

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Ex-Program Director, National Science Foundation, USA

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IIT Delhi, India

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Northeastern University, USA

Anil Roy

DAU Gandhinagar, India

JOIN US FOR THE 4TH INTERNATIONAL IEEE APPLIED SENSING CONFERENCE (APSCON) ON FEBRUARY 23-25, 2026 IN NEW DELHI, INDIA!

CONFERENCE TRACKS

APSCON 2026 invites original research papers (not being considered for publication elsewhere) of 4 pages in standard IEEE conference template on applications of sensors and sensing techniques in one of the following ten tracks (but are not limited to):

- » Agriculture and Food Technology
- » Transportation Systems
- » Medical and Digital Healthcare
- » Manufacturing and Automation
- » Environment and climate change Monitoring
- » Infrastructure and Sustainability
- » Robotics and Digital Twin
- » Wearables and Immersive Technologies
- » Analytical Instrumentation
- » Emerging Quantum Technologies

Other Sessions

Session I: Live Demo

Session II: Student Research Forum

Session III: Journal pre-published paper

Session IV: Sensors Letters (SL) re-Routed papers Option A

Session V: Direct to Sensors Letters papers Option B

Special Session

- » Special Session: AI for Sensing

Publication of Papers in Conference Proceedings and IEEE Sensors Letters

Authors get two options of submissions:

- » **Option A:** to the conference through Epapers portal
- » **Option B:** direct to the IEEE Sensors Letters through ScholarOne manuscripts (<https://mc.manuscriptcentral.com/sensors-letters>).

Papers submitted to Option A will be reviewed by the Technical Program Committee of APSCON 2026 for quality and scope. If accepted, the authors will be able to present their work during the conference. Such papers submitted and accepted via Option A will be published in the conference Proceedings.

Papers submitted via Option B will be reviewed by the editorial team of IEEE Sensors Letters and will be published directly in this journal, if accepted. Authors of such papers are expected to present their work during APSCON 2026, provided the topic aligns with the scope of the conference. Papers that are not accepted under Option B may be submitted via Option A after appropriately addressing reviewers' comments form IEEE Sensors letters.

For detail, visit: <https://2026.ieee-apscon.org>

Industry Day

Full of industry-led activities, thematic round-table meetings, focused sessions, keynote talks, tutorials/workshops.

Sensors Startup Summit

The emerging ecosystem of startups will be invited to network and get together to share their success-stories, opportunities, marketplace and technological challenges. Live Demos of their business model is also invited.

Students Research Forum

We invite advanced stage PhD work and completed theses (not older than 6 months), MTech/MS theses and undergrad high level research projects to present and get inputs from the experts. This will give these aspiring students a platform to network, improve their work besides exploring post-doctoral opportunities and/or job offers.

Sensors Standards Opportunities

IEEE Sensors Council's Standards Committee invites you to explore sensors domains standards development opportunities while sharing an overview of its activities.

For more information please visit 2026.ieee-apscon.org